DATA SHEET

UAA3201TUHF/VHF remote control receiver

Preliminary specification Supersedes data of September 1993 File under Integrated Circuits, IC18 1995 May 18







UAA3201T

FEATURES

- · Oscillator with external SAW resonator
- Wide frequency range: 150 to 450 MHz
- · High sensitivity
- · Low power consumption
- · Automotive temperature range
- · Superheterodyne architecture
- Applicable to fulfil FTZ17TR2100
- · High integration level, few external components
- · Inexpensive external components
- · IF-filter bandwidth determined by application.

APPLICATIONS

- · Car alarm systems
- · Remote control systems
- · Security systems
- · Gadgets, toys
- · Telemetry.

GENERAL DESCRIPTION

The UAA3201T is a fully integrated single chip receiver, primarily intended for use in VHF and UHF systems employing direct AM Return-to-Zero (RZ) Amplitude Shift Keying (ASK) modulation.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{CC}	supply voltage		3.5	_	6.0	V
Icc	supply current		_	3.4	4.8	mA
P _{ref}	sensitivity	$\begin{aligned} & f_i = 433.92 \text{ MHz;} \\ & \text{data rate 250 bits/s;} \\ & \text{BER} \leq 3 \times 10^{-2} \end{aligned}$	_	_	-105	dBm
T _{amb}	operating ambient temperature		-40	-	+85	°C

ORDERING INFORMATION

TYPE		PACKAGE	2.447	
NUMBER NAME		DESCRIPTION	VERSION	
UAA3201T	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1	

7110826 0089662 173

UAA3201T

BLOCK DIAGRAM

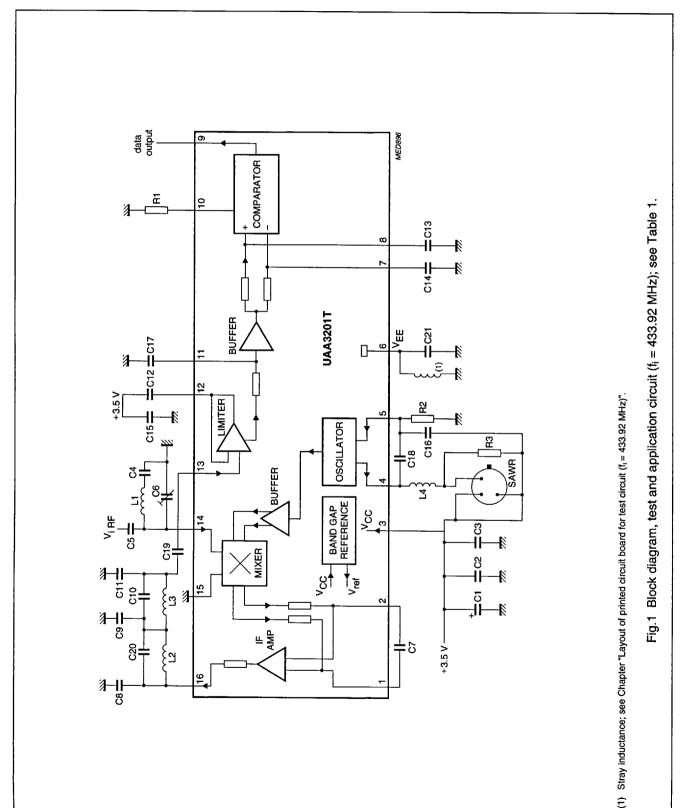


Table 1 Application component list for Fig.1

COMPONENT	VALUE	TOLERANCE	DESCRIPTION
R1	27 kΩ	±2%	TC = +50 ppm/K
R2	680 Ω	±2%	TC = +50 ppm/K
R3	220 Ω	±2%	TC = +50 ppm/K
C1	4.7 μF	±20%	-
C2	150 pF	±10%	TC = 0 ±30 ppm/K; $\tan \delta \le 10 \times 10^{-4}$; f = 1 MHz
C3	1 nF	±10%	TC = 0 ±30 ppm/K; $\tan \delta \le 10 \times 10^{-4}$; f = 1 MHz
C4	820 pF	±10%	TC = 0 ±30 ppm/K; $\tan \delta \le 10 \times 10^{-4}$; f = 1 MHz
C5	3.3 pF	±10%	TC = 0 ± 150 ppm/K; $\tan \delta \le 30 \times 10^{-4}$; f = 1 MHz
C6	2.5 to 6 pF	-	TC = $0 \pm 300 \text{ ppm/K}$; $\tan \delta \le 20 \times 10^{-4}$; f = 1 MHz
C7	56 pF	±10%	TC = 0 ± 30 ppm/K; $\tan \delta \le 10 \times 10^{-4}$; f = 1 MHz
C8	150 pF	±10%	TC = $0 \pm 30 \text{ ppm/K}$; $\tan \delta \le 10 \times 10^{-4}$; f = 1 MHz
C9	220 pF	±10%	TC = 0 ±30 ppm/K; $\tan \delta \le 10 \times 10^{-4}$; f = 1 MHz
C10	27 pF	±10%	TC = 0 ±30 ppm/K; $\tan \delta \le 20 \times 10^{-4}$; f = 1 MHz
C11	150 pF	±10%	TC = 0 ±30 ppm/K; $\tan \delta \le 10 \times 10^{-4}$; f = 1 MHz
C12	100 nF	±10%	$\tan \delta \le 25 \times 10^{-3}$; f = 1 kHz
C13	2.2 nF	±10%	$\tan \delta \le 25 \times 10^{-3}$; f = 1 kHz
C14	33 nF	±10%	$\tan \delta \le 25 \times 10^{-3}$; f = 1 kHz
C15	150 pF	±10%	TC = 0 ±30 ppm/K; $\tan \delta \le 10 \times 10^{-4}$; f = 1 MHz
C16	3.9 pF	±10%	TC = 0 ± 150 ppm/K; $\tan \delta \le 30 \times 10^{-4}$; f = 1 MHz
C17	10 nF	±10%	$\tan \delta \le 25 \times 10^{-3}$; f = 1 kHz
C18	3.3 pF	±10%	TC = 0 ±150 ppm/K; $\tan \delta \le 30 \times 10^{-4}$; f = 1 MHz
C19	68 pF	±10%	TC = 0 ±30 ppm/K; $\tan \delta \le 10 \times 10^{-4}$; f = 1 MHz
C20	6.8 pF	±10%	TC = 0 ± 150 ppm/K; $\tan \delta \le 30 \times 10^{-4}$; f = 1 MHz
C21	47 pF	±5%	TC = 0 ±30 ppm/K; $\tan \delta \le 10 \times 10^{-4}$; f = 1 MHz
L1	10 nH	±10%	Q _{min} = 50/450 MHz; TC = +25 to +125 ppm/K
L2	330 μΗ	±10%	Q _{min} = 45/800 kHz; C _{stray} ≤ 1 pF
L3	330 μΗ	±10%	Q _{min} = 45/800 kHz; C _{stray} ≤ 1 pF
L4	33 nH	±10%	Q _{min} = 45/450 MHz; TC = +25 to +125 ppm/K

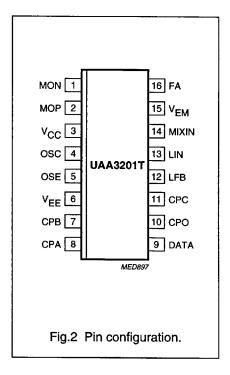
Table 2 SAWR (Surface Acoustic Wave Resonator) data

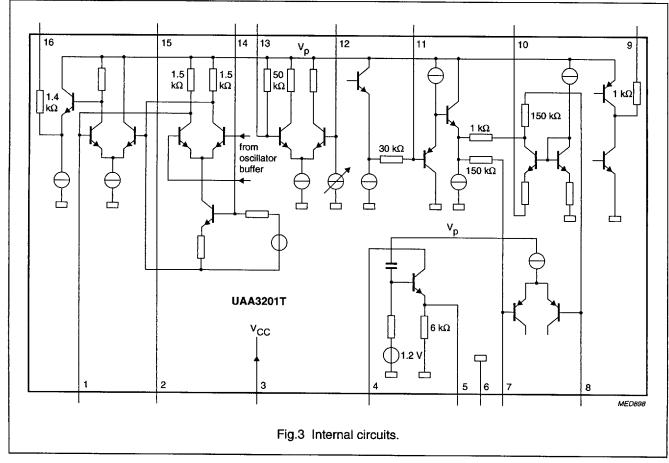
DESCRIPTION	SPECIFICATION				
Туре	one-port (e.g. RFM R02112)				
Centre frequency	433.42 MHz ±75 kHz				
Maximum insertion loss	1.5 dB				
Typical loaded Q	1600 (50 Ω load)				
Temperature drift	0.032 ppm/K ²				
Turnover temperature	43 °C				

UAA3201T

PINNING

SYMBOL	PIN	DESCRIPTION
MON	1	negative mixer output
МОР	2	positive mixer output
V _{CC}	3	positive supply voltage
OSC	4	oscillator collector
OSE	5	oscillator emitter
V _{EE}	6	negative supply voltage
СРВ	7	comparator input B
CPA	8	comparator input A
DATA	9	data output
CPO	10	comparator offset adjustment
CPC	11	comparator input C
LFB	12	limiter feedback
LIN	13	limiter input
MIXIN	14	mixer input
V _{EM}	15	negative supply voltage for mixer
FA	16	output to elliptic filter





UAA3201T

FUNCTIONAL DESCRIPTION

The RF signal is fed directly into the mixer stage where it is mixed down to nominal 500 kHz IF by the integrated SAWR controlled oscillator. The IF signal is then passed to the IF amplifier which increases the level. A 5th order elliptic low-pass filter acts as the main IF filtering. The output voltage of that filter is demodulated by a limiting amplifier that rectifies the incoming IF. The demodulated signal passes two RC filter stages and is then limited by a data comparator which makes it available at the data output pin.

Mixer

The mixer is a single balanced emitter coupled pair with internally set bias current. The optimum impedance is 320 Ω at 430 MHz. Capacitor C5 is used to transform a 50 Ω generator impedance to the optimum value.

Oscillator

The oscillator consists of a transistor in common base configuration and a tank circuit including the SAWR. R2 is used to control the bias current through the transistor. R3 is required to reduce unwanted responses of the tank circuit.

IF amplifier

The IF amplifier is a differential input, single ended output emitter coupled pair. It is used to decouple the first and the second IF filter and to provide some additional gain in order to reduce the influence of the noise of the limiter on the total noise figure.

IF filters

The first IF filter is an RC filter formed by internal resistors and an external capacitor. The second IF filter is an external elliptic filter. The source impedance is 1.4 k Ω , the load is high impedance. The bandwidth of the IF filter in the given application is 800 kHz due to the centre frequency spread of the SAWR. It may be reduced when SAWRs with less tolerances are used or temperature range requirements are lower. A smaller bandwidth of the filter will yield a higher sensitivity of the receiver. As the RF is mixed down to a low IF there is no image rejection possible.

Limiter

The limiting amplifier consists of three DC-coupled amplifier stages, with a total gain of 60 dB. An RSSI signal is generated by rectifying the IF signal. The limiter has a lower frequency limit of 100 kHz, which can be controlled by C12 and C19, and an upper frequency limit of 3 MHz.

Comparator

The $2 \times IF$ component in the RSSI signal is removed by the first order low-pass capacitor C17. After passing a buffer stage the signal is split into two paths, leading via RC filters to the inputs of a voltage comparator. The time constant of one path (C14) is compared to the bit duration. Consequently the potential at the negative comparator input represents the average magnitude of the RSSI signal, the second path with a short time constant (C13) allows the signal at the positive comparator input to follow the RSSI signal instantaneously. This results in a variable comparator threshold, depending on the field strength of the incoming signal.

Hence the comparator output is switched on, when the RSSI signal exceeds its average value, i.e. when an ASK ON signal is received.

The low-pass filter capacitor C13 rejects the unwanted $2 \times IF$ and reduces the noise bandwidth of the data filter. The resistor R1 is used to set the current of an internal source. This current is drawn from the positive comparator input thereby applying an offset and driving the output into the OFF state during the absence of an input signal. This offset can be increased by lowering the value of R1 yielding a higher noise immunity at the expense of reduced sensitivity.

Band gap reference

The band gap reference controls the biasing of the whole circuit. In this block currents are generated that are constant over temperature and currents that are proportional to absolute temperature.

The current consumption of the receiver rises with increasing temperature, because the blocks with the highest current consumption are biased by currents that are proportional to absolute temperature.

UAA3201T

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS.	MIN.	MAX.	UNIT
V _{CC}	supply voltage		-0.3	+8.0	V
T _{amb}	operating ambient temperature		-40	+85	°C
T _{stg}	storage temperature		-55	+125	°C
V _{es}	electrostatic handling	note 1			
	pins 4 and 5		-2000	+1500	V
	pins 12 and 14		-1500	+2000	v
	all other pins		_	±2000	V

Note

1. Human body model: equivalent to discharging a 100 pF capacitor through a 1.5 k Ω series resistor.

DC CHARACTERISTICS

All voltages referenced to V_{EE} ; V_{CC} = 3.5 V; T_{amb} = -40 to +85 °C; typical values for T_{amb} = +25 °C; for test circuit see Fig.1; SAWR disconnected; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{CC}	supply voltage		3.5	_	6.0	V
V _{DATA}	data output voltage	$I_{DATA} = -10 \mu A$ (HIGH); note 1	V _{CC} - 0.5	_	_	V
		I _{DATA} = +200 μA (LOW); note 1	-	_	0.6	V
lcc	supply current	$R_2 = 680 \Omega$		3.4	4.8	mA

Note

1. IDATA is defined to be positive when current flows into the DATA pin.

UAA3201T

AC CHARACTERISTICS

 $V_{CC} = 3.5 \text{ V}$; $T_{amb} = +25 \,^{\circ}\text{C}$; test circuit (see Fig.1); R1 disconnected; for test board see Figs 10 and 11; for AC test conditions see Section "AC test conditions"; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
P _{ref}	input sensitivity	BER ≤ 3 × 10 ⁻² ; note 1	_	_	-105	dBm
P _{i(max)}	maximum input power	BER ≤ 3 × 10 ⁻²	_	_	-30	dBm
P _{spur}	spurious radiation	note 2	_	_	-60	dBm
IP3 _{mix}	intercept point (mixer)		-20	-17	_	dBm
IP3 _{IF}	intercept point (mixer + IF amplifier)		-38	-35	_	dBm
P _{1 dB}	1 dB compression point (mixer)		-38	-35	_	dBm
ton	receiver turn-on time	note 3	-	1-	10	ms

Notes

- 1. P_{ref} is the maximum available power at the input of the test board. The Bit Error Rate (BER) is measured using the test facility shown in Fig.9.
- 2. Valid only for the reference PCB (see Figs 10 and 11). Spurious radiation is strongly dependent on the PCB layout.
- 3. C1 disconnected. The supply voltage V_{CC} is pulsed as explained in the Section "AC test conditions".

TEST INFORMATION

Tuning procedure for AC tests

- 1. Turn on the signal generator (f_i = 433.92 MHz; no modulation; RF input level = 1 mV).
- 2. Tune C6, RF stage input, to obtain a peak audio voltage on pin LIN.
- Check that data is appearing on the data output pin, DATA, and proceed with the AC tests.

AC test conditions

Table 3 Test signals

The reference signal level P_{ref} for the following tests is defined as the minimum input level in dBm to give a BER $\leq 3 \times 10^{-2}$ (e.g. 7.5 bit errors per second for 250 bits/s).

TEST FREQUENCY (MHz) 1 433.92 2		DATA SIGNAL	MODULATION	MODULATION INDEX
		250 bits/s square wave	RZ signal with duty cycle = 66% for logic 1; RZ signal with duty cycle = 33% for logic 0	100%
2	434.02	_	no modulation	_
3	433.92	_	no modulation	_

UAA3201T

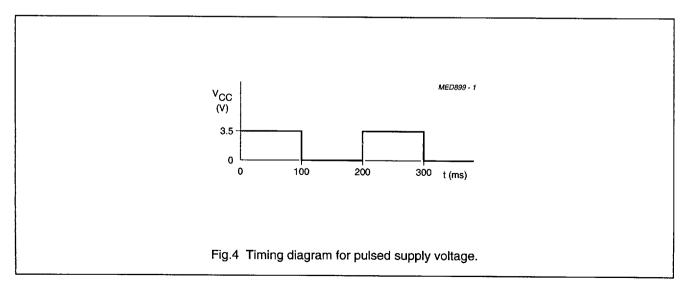
Table 4 Test results

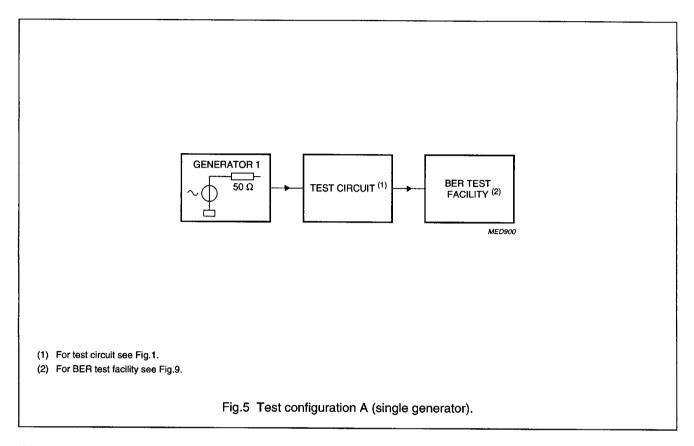
 P_1 is the maximum available power from signal generator 1 at the input of the test board; P_2 is the maximum available power from signal generator 2 at the input of the test board.

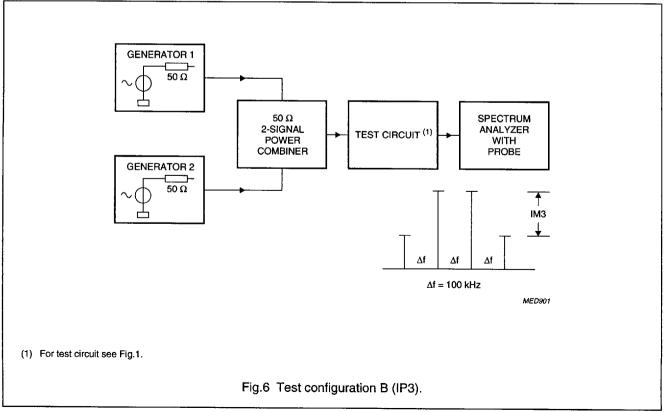
TEST	GENERATOR	}	DEGULT			
1231	1	2	RESULT			
Maximum input power (see Fig.5)	modulated test signal 1; $P_1 = -30 \text{ dBm}$ (minimum P_{max})	_	BER $\leq 3 \times 10^{-2}$ (e.g. 7.5 bit errors per second for 250 bits/s)			
Receiver turn-on time; see note 1 and Fig.5	test signal 1; $P_1 = P_{ref} + 10 \text{ dB}$; error counting is started 10 ms after V_{CC} is switched on		check that the first 10 bits are correct			
Intercept point (mixer) see note 2 and Fig.6	test signal 3; P ₁ = -50 dBm	test signal 2; $P_2 = P_1$	IP3 = P ₁ + $\frac{1}{2}$ × IM3 (dB); IP3 ≥ -20 dBm (minimum IP3 _{mix})			
Intercept point (mixer + IF amplifier) see note 3 and Fig.6	test signal 3; P ₁ = -50 dBm	test signal 2; P ₂ = P ₁	IP3 = P ₁ + $\frac{1}{2}$ × IM3 (dB); IP3 \ge -38 dBm (minimum IP3 _{IFa})			
Spurious radiation see note 4 and Fig.7		_	no spuriouses (25 MHz - 1 GHz) with level higher than -60 dBm (maximum P _{spur})			
1 dB compression point (mixer) see note 5 and Fig.8	test signal 3; $P_{11} = -70 \text{ dBm}$; $P_{12} = -38 \text{ dBm}$ (minimum $P_{1 \text{ dB}}$)	_	$(P_{o1} + 70 \text{ dB}) - [P_{o2} + 38 \text{ dB (minimum}$ $P_{1 \text{ dB}})] \le 1 \text{ dB, where } P_{o1}, P_{o2} \text{ is the output power}$ for test signals with P_{11} or P_{12} , respectively			

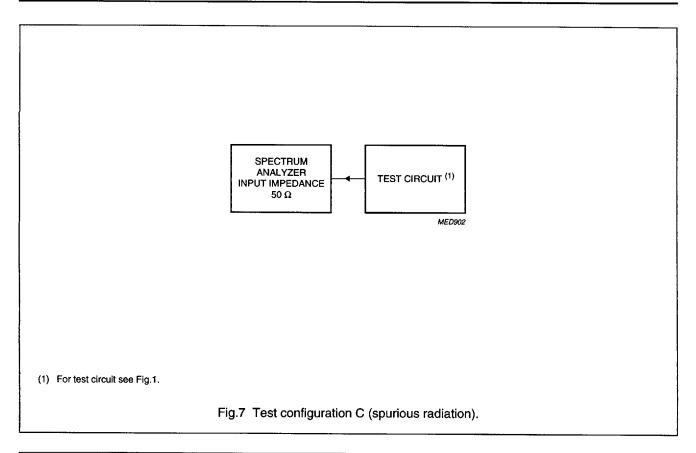
Notes

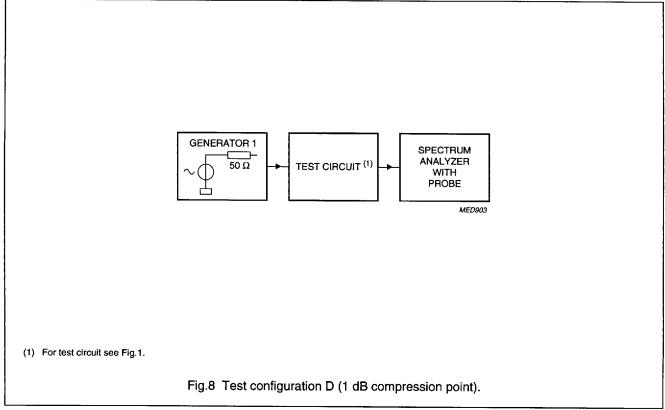
- 1. The supply voltage V_{CC} of the test circuit alternates between 'on' (100 ms) and 'off' (100 ms); see Fig.4.
- Differential probe of spectrum analyser connected to MOP and MON.
- 3. Probe of spectrum analyser connected to LIN.
- 4. Spectrum analyser connected to the input of the test board.
- 5. Probe of spectrum analyser connected to either MOP or MON.

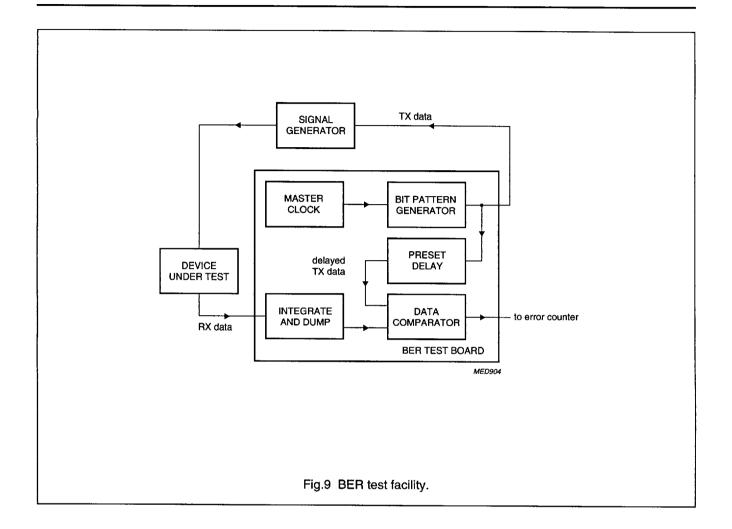






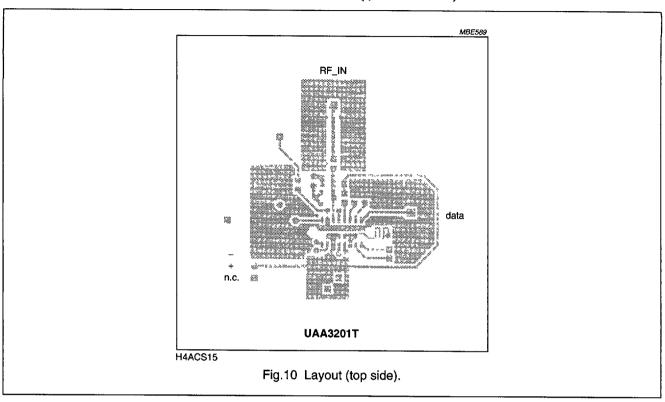


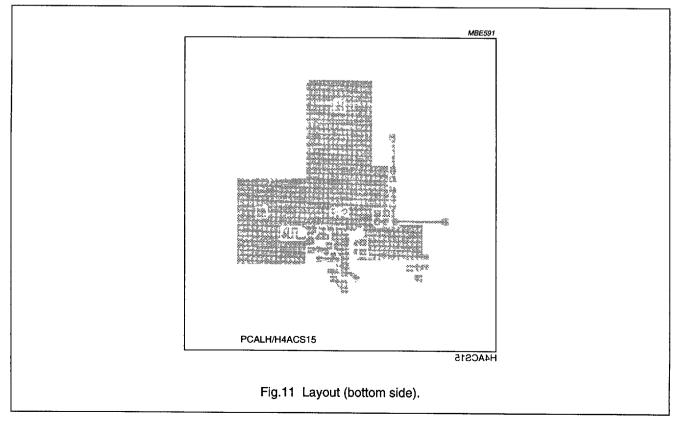


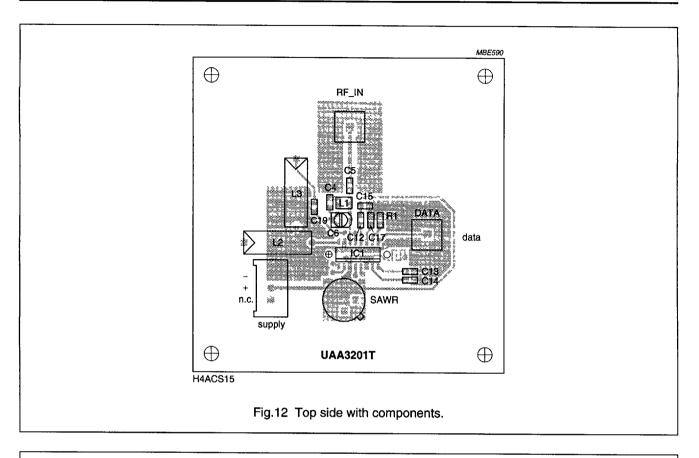


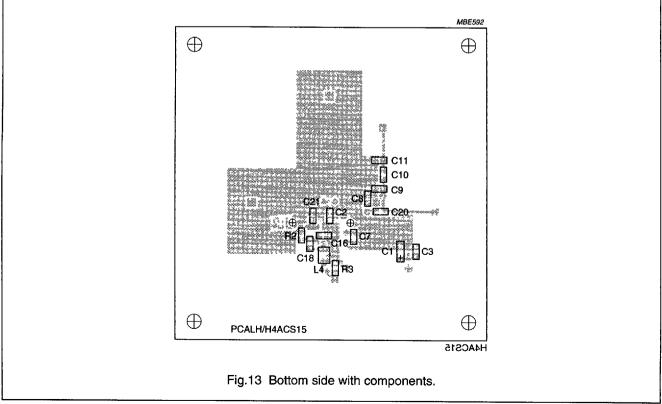
UAA3201T

LAYOUT OF PRINTED CIRCUIT BOARD FOR TEST CIRCUIT (f; = 433.92 MHz)







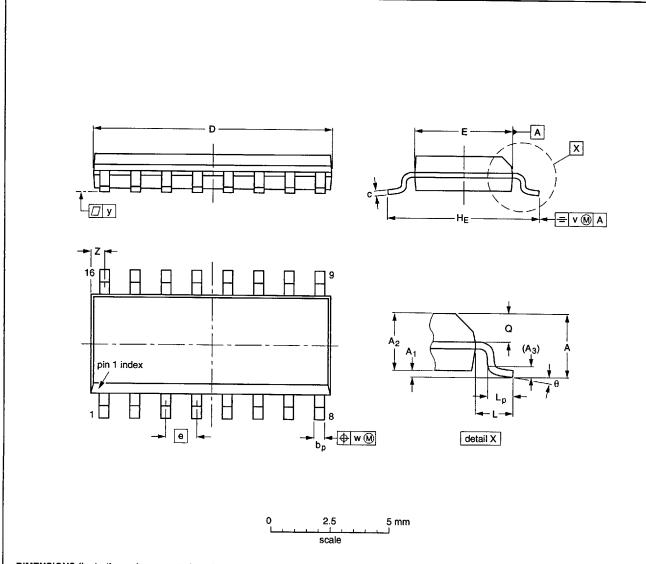


UAA3201T

PACKAGE OUTLINE

SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	Aз	bр	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	10.0 9.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	80
ınches		0.0098 0.0039		0.01		0.0098 0.0075	0.39 0.38	0.16 0.15	0.050	0.24 0.23	0.041	0.039 0.016		0.01	0.01	0.004	0.028 0.012	00

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFERE	NCES	EUROPEAN	
VERSION IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT109-1	076E07S	MS-012AC			91-08-13 95-01-23

UAA3201T

SOLDERING

Plastic small-outline packages

BY WAVE

During placement and before soldering, the component must be fixed with a droplet of adhesive. After curing the adhesive, the component can be soldered. The adhesive can be applied by screen printing, pin transfer or syringe dispensing.

Maximum permissible solder temperature is 260 °C, and maximum duration of package immersion in solder bath is 10 s, if allowed to cool to less than 150 °C within 6 s. Typical dwell time is 4 s at 250 °C.

A modified wave soldering technique is recommended using two solder waves (dual-wave), in which a turbulent wave with high upward pressure is followed by a smooth laminar wave. Using a mildly-activated flux eliminates the need for removal of corrosive residues in most applications.

BY SOLDER PASTE REFLOW

Reflow soldering requires the solder paste (a suspension of fine solder particles, flux and binding agent) to be

applied to the substrate by screen printing, stencilling or pressure-syringe dispensing before device placement.

Several techniques exist for reflowing; for example, thermal conduction by heated belt, infrared, and vapour-phase reflow. Dwell times vary between 50 and 300 s according to method. Typical reflow temperatures range from 215 to 250 °C.

Preheating is necessary to dry the paste and evaporate the binding agent. Preheating duration: 45 min at 45 °C.

REPAIRING SOLDERED JOINTS (BY HAND-HELD SOLDERING IRON OR PULSE-HEATED SOLDER TOOL)

Fix the component by first soldering two, diagonally opposite, end pins. Apply the heating tool to the flat part of the pin only. Contact time must be limited to 10 s at up to 300 °C. When using proper tools, all other pins can be soldered in one operation within 2 to 5 s at between 270 and 320 °C. (Pulse-heated soldering is not recommended for SO packages.)

For pulse-heated solder tool (resistance) soldering of VSO packages, solder is applied to the substrate by dipping or by an extra thick tin/lead plating before package placement.

DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
1	

Limiting values

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.